

Notice of References Cited	Application/Control No. 10/724,741	Applicant(s)/Patent Under Reexamination SHEU ET AL.	
	Examiner Ashok Patel	Art Unit 2879	Page 1 of 1

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	B	US-6,617,798 B2	09-2003	Lee et al.	315/169.3
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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